# Problem Set 1: MOS (Biasing + Small-Signal Model)

## **Chapter 6 (MOS Device)**

In the following problems, unless otherwise stated, assume  $\mu_n C_{ox} = 200 \ \mu A/V^2$ ,  $\mu_p C_{ox} = 100 \ \mu \text{A/V}^2$ , and  $V_{TH} = 0.4 \ \text{V}$  for NMOS devices and  $-0.4 \ \text{V}$  for PMOS

#### Problem 6.24

In the Fig. 6.42, what is the minimum allowable value of  $V_{DD}$  if  $M_1$  must not enter the triode region? Assume  $\lambda = 0$ .

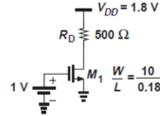


Figure 6.42

#### Problem 6.31

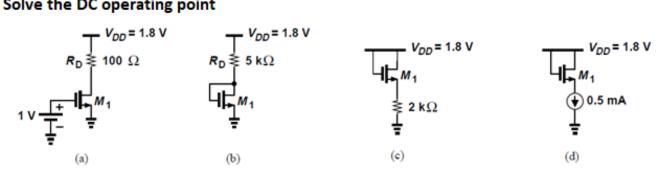
An NMOS device operating in saturation with  $\lambda = 0$  must provide a transconductance of  $1/(50 \Omega)$ .

- (a) Determine W/L if  $I_D = 0.5$  mA.
- (b) Determine W/L if  $V_{GS} V_{TH} = 0.5 \text{ V}$ .
- (c) Determine  $I_D$  if  $V_{GS} V_{TH} = 0.5$  V.

### **Problem 6.33 (b, d)**

If  $\lambda = 0.1 \text{ V}^{-1}$  and W/L = 20/0.18, construct the small-signal model of each of the circuits shown

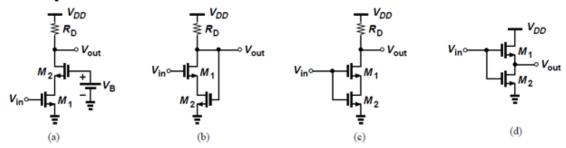
## Solve the DC operating point



## **Problem 6.38 (d)**

Construct the small-signal model of the circuits depicted in Fig. 6.50. Assume all transistors operate in saturation and  $\lambda \neq 0$ .

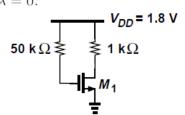
#### Find an expression for Rin and Rout



## **Chapter 7 (Biasing Techniques & Input / Output Impedance)**

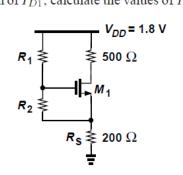
#### **Problem 7.1**

In the circuit of Fig. 7.39, determine the maximum allowable value of W/L if  $M_1$  must remain in saturation. Assume  $\lambda = 0$ .



#### **Problem 7.5**

Consider the circuit depicted in Fig. 7.43, where W/L=20/0.18. Assuming the current flowing through  $R_2$  is one-tenth of  $I_{D1}$ , calculate the values of  $R_1$  and  $R_2$  so that  $I_{D1}=0.5$  mA.



Consider the circuit shown in Fig. 7.52, where  $(W/L)_1=10/0.18$  and  $(W/L)_2=30/0.18$  if  $\lambda=0.1~\rm V^{-1}$ , calculate  $V_B$ 

